


<b>Search Notes</b> 	<b>Application/Control No.</b> 10651058	<b>Applicant(s)/Patent Under Reexamination</b> SHIMADA ET AL.
	<b>Examiner</b> Chawan, Sheela C	<b>Art Unit</b> 2624

SEARCHED			
Class	Subclass	Date	Examiner
382	181,187,317	1/8/07	SCC
707	2,3,10	"	"
715	508,506	"	"
706	14,25,41	"	"
435	193,320.1,325,252.3	"	"
434	353,362,358,201	"	"
536	23.2 <i>u</i>	"	"

SEARCH NOTES		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST, US-PGPUB,USPAT,EPO,JPO,DERWENT,IBM-TDB.	1/8/07	SCC
INVENTOR NAME SEARCH.	"	"
<i>update to search</i>	<i>8/4/07</i>	<i>SCC</i>

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner